

<b>Notice of References Cited</b>	Application/Control No. 10/083,617	Applicant(s)/Patent Under Reexamination AOKI ET AL.	
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	B	US-2002/0109897	08-2002	Mirshekar-Syahkal et al.	359/245
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	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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